## Notice of References Cited Application/Control No. 10/074,650 Examiner Djenane M Bayard Applicant(s)/Patent Under Reexamination TANG ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,247,048	06-2001	Greer et al.	709/219
	В	US-5,956,490	09-1999	Buchholz et al.	709/245
	С	US-2002/0156872	10-2002	Brown, David W.	709/219
	D	US-2003/0023628	01-2003	Girardot et al.	707/513
	Е	US-2001/0032254	10-2001	HAWKINS, JEFFREY C.	709/219
	F	US-2002/0091738	07-2002	Rohrabaugh et al.	707/517
	G	US-2005/0004875	01-2005	Kontio et al.	705/052
	н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	·				
	0					
	Р					
	Q					
	R					
	S					
	Т	·				

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.